Notice of References Cited Application/Control No. 10/566,395 Examiner BRUK A. GEBREMICHAEL Applicant(s)/Patent Under Reexamination SHIMURA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,886,683 A	03-1999	Tognazzini et al.	715/700
*	В	US-6,155,834 A	12-2000	New, III, Cecil A.	434/118
*	С	US-6,341,959 B1	01-2002	Wen et al.	434/169
*	D	US-2002/0059031 A1	05-2002	Shimura et al.	702/19
*	Е	US-2002/0076675 A1	06-2002	Budra et al.	434/167
*	F	US-6,461,166 B1	10-2002	Berman, Dennis Ray	434/323
*	G	US-2002/0156632 A1	10-2002	Haynes et al.	704/270
*	Η	US-2002/0187824 A1	12-2002	Vancura, Olaf	463/16
*	I	US-2003/0077559 A1	04-2003	Braunberger et al.	434/322
*	J	US-6,551,109 B1	04-2003	Rudmik, Tom R.	434/322
*	К	US-2003/0087223 A1	05-2003	Walker et al.	434/353
*	L	US-2003/0093275 A1	05-2003	Polanyi et al.	704/251
*	М	US-2004/0009462 A1	01-2004	McElwrath, Linda Kay	434/350

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-I ATENT BOOOMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.